

<p>Search Notes</p> 				<p>Application/Control No.</p> <p>10/574,668</p> <p>Examiner</p> <p>LEE NGUYEN</p>		<p>Applicant(s)/Patent under Reexamination</p> <p>IKEDA ET AL.</p> <p>Art Unit</p> <p>2618</p>	
SEARCHED				SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
Class	Subclass	Date	Examiner			DATE	EXMR
455	567	11/14/2007	LN	EAST (USPG-PUB; USPAT; JPO; EPO; DERWENT) SEE SEARCH HISTORY		11/14/2007	LN
	518						
	519						
340	7.58						
	7.59						
	7.6						
	7.62						
INTERFERENCE SEARCHED							
Class	Subclass	Date	Examiner				
455	566	11/21/2007	LN				
340	7.58						
SEE SEARCH HISTORY		11/21/2007	LN				